

**Notice of References Cited**

Application/Control No.

09/381,996

Applicant(s)/Patent Under

Reexamination

YAMADA ET AL.

Examiner

Shin-Hon Chen

Art Unit

2131

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**U.S. PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
	A	US-			
	B	US-			
	C	US-			
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	E	US-			
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	K	US-			
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**FOREIGN PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N	EP 794496 A1	09-1997	European Patent	SAKO et al.	G06F 12/14
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	P					
	Q					
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**NON-PATENT DOCUMENTS**

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